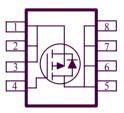
P-Channel 30-V (D-S) MOSFET

These miniature surface mount MOSFETs utilize High Cell Density process. Low $r_{DS(on)}$ assures minimal power loss and conserves energy, making this device ideal for use in power management circuitry. Typical applications are PWMDC-DC converters, power management in portable and battery-powered products such as computers, printers, battery charger, telecommunication power system, and telephones power system.

- Low r_{DS(on)} Provides Higher Efficiency and Extends Battery Life
- Miniature SO-8 Surface Mount Package Saves Board Space
- High power and current handling capability
- Extended VGS range (±25) for battery pack applications

PRODUCT SUMMARY				
V _{DS} (V)	$r_{\mathrm{DS(on)}} m(\Omega)$	I _D (A)		
-30	$30 @ V_{GS} = -10V$	9.5		
	$52 @ V_{GS} = -4.5V$	7.5		





ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C UNLESS OTHERWISE NOTED)						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V _{DS}	-30	V		
Gate-Source Voltage		V _{GS}	±25	v		
Continuous Drain Current ^a	$T_A=25^{\circ}C$	т	9.5			
Continuous Drain Current	$T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$	тD	8.3	А		
Pulsed Drain Current ^b		I _{DM}	±50			
Continuous Source Current (Diode Conduction) ^a		Is	-2.1	А		
	$T_A=25^{\circ}C$	л	3.1	W		
Power Dissipation ^a	$T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$	гD	2.6	vv		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to 150	°C		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case ^a	t <= 5 sec	$R_{\theta JC}$	25	°C/W	
Maximum Junction-to-Ambient ^a	t <= 10 sec	$R_{\theta JA}$	50	°C/W	

Notes

a. Surface Mounted on 1" x 1" FR4 Board.

b. Pulse width limited by maximum junction temperature

Parameter	Symbol		Limits			Unit	
Farameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
Static							
Drain-Source Breakdown Voltage	V(BR)DSS	$V_{GS} = 0 V$, $I_D = -250 uA$	-30			v	
Gate-Threshold Voltage	VGS(th)	$V_{DS} = V_{GS}, I_D = -250 \text{ uA}$	-1	-1.6	-3	v	
Gate-Body Leakage	Igss	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			±100	nA	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -24 V, V_{GS} = 0 V$			-1	uA	
Zelo Gate voltage Dialii Current	IDSS	$V_{DS} = -24 V, V_{GS} = 0 V, T_J = 55^{\circ}C$			-5	uA	
On-State Drain Current ^A	ID(on)	$V_{DS} = -5 V$, $V_{GS} = -10 V$	-50			Α	
	IDS(on)	$V_{GS} = -10 V$, $I_D = -9.5 A$		24	30		
Drain-Source On-Resistance ^A		$V_{GS} = -4.5 \text{ V}, I_D = -7.5 \text{ A}$		44	52	mΩ	
		$V_{GS} = -10 V$, $I_D = -9.5 A$, $TJ = 55^{\circ}C$		29	36		
Forward Tranconductance ^A	g _{fs}	$V_{DS} = -15 \text{ V}, \text{ I}_D = -9.5 \text{ A}$		31		S	
Diode Forward Voltage	Vsd	$I_{S} = -2.1 A, V_{GS} = 0 V$		-0.7	-1.2	V	
Dynamic ^b							
Total Gate Charge	Qg	$X_{2} = 15 X X_{2} = 10 X$		15	26		
Gate-Source Charge	Qgs	$V_{DS} = -15 V, V_{GS} = -10 V,$ $I_{D} = -9 5 A$		5.8		nC	
Gate-Drain Charge	Qgd	1D – -9.5 A		12			
Switching							
Turn-On Delay Time	td(on)			15	26		
Rise Time	tr	V_{DD} = -15 V, R_L = 15 Ω , ID = -1 A,		12	21	nS	
Turn-Off Delay Time	td(off)	$VGEN = -10 V, RG = 6\Omega$		62	108	115	
Fall-Time	tf			46	71]	

Notes

a. Pulse test: $PW \le 300$ us duty cycle $\le 2\%$.

b. Guaranteed by design, not subject to production testing.

Analog Power (APL) reserves the right to make changes without further notice to any products herein. APL makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does APL assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in APL data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. APL does not convey any license under its patent rights nor the rights of others. APL products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the APL product could create a situation where personal injury or death may occur. Should Buyer purchase or use APL products for any such unintended or unauthorized application, Buyer shall indemnify and hold APL and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that APL was negligent regarding the design or manufacture of the part. APL is an Equal Opportunity/Affirmative Action Employer.

Typical Electrical Characteristics (P-Channel)

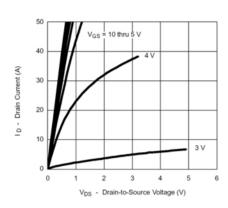


Figure 1. On-Region Characteristics

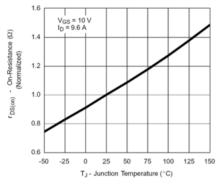
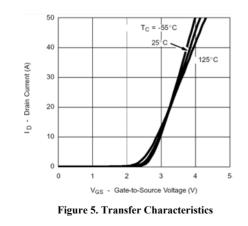


Figure 3. On-Resistance Variation

with Temperature



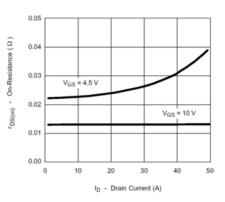
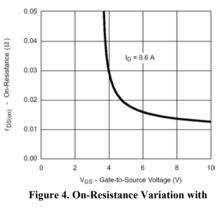


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage



Gate to Source Voltage

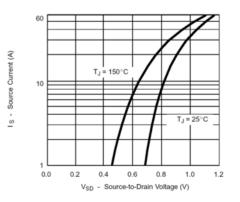
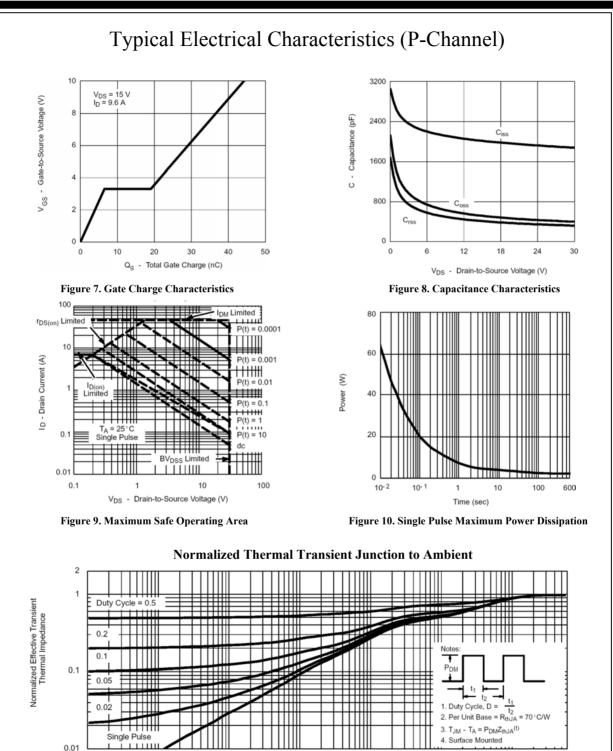


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

September, 2002 - Rev. A PRELIMINARY

 $^{\odot}$



10-4

10-3

10-2

100

600

Square Wave Pulse Duration (sec) Figure 11. Transient Thermal Response Curve

10-1

1

10

